Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10688517	HONG, SEI-WON
Examiner	Art Unit
Lavin, Christopher L	2624

	SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTE	E S	
Search Notes	Date	Examiner
East Search	05/16/07	CLL

INTERFERENCE SEARCH					
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